

MOSFET

OptiMOS™ 3 Power-Transistor, 120 V

Features

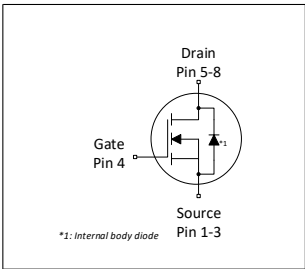
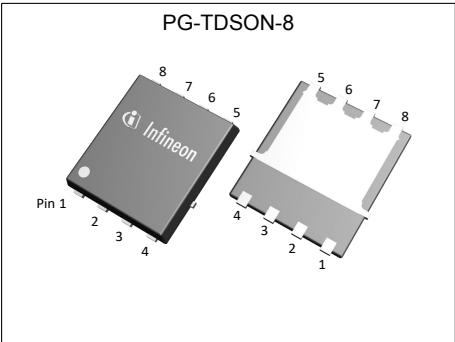
- N-channel, logic level
- Excellent gate charge x RDS(on) product (FOM)
- Very low on-resistance RDS(on)
- 150 °C operating temperature
- Pb-free lead plating; RoHS compliant
- Ideal for high-frequency switching and synchronous rectification
- Halogen-free according to IEC61249-2-21

Product validation

Fully qualified according to JEDEC for Industrial Applications

Table 1 Key Performance Parameters

| Parameter | Value | Unit |
|------------------|-------|------|
| V_{DS} | 120 | V |
| $R_{DS(on),max}$ | 8.0 | mΩ |
| I_D | 99 | A |
| Q_{oss} | 79 | nC |
| $Q_G(0V..10V)$ | 79 | nC |



RoHS

| Type / Ordering Code | Package | Marking | Related Links |
|----------------------|------------|----------|---------------|
| BSC080N12LS | PG-TDSON-8 | 080N12LS | - |

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1 Maximum ratings

at $T_A=25\text{ °C}$, unless otherwise specified

Table 2 Maximum ratings

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|---|-------------------|--------|------|----------------|------|---|
| | | Min. | Typ. | Max. | | |
| Continuous drain current | I_D | - | - | 99 77 12 | A | $V_{GS}=10\text{ V}$, $T_C=25\text{ °C}$ $V_{GS}=10\text{ V}$, $T_C=100\text{ °C}$ $V_{GS}=4.5\text{ V}$, $T_A=25\text{ °C}$, $R_{thJA}=45\text{ °C/W}^{(1)}$ |
| Pulsed drain current ⁽²⁾ | $I_{D,pulse}$ | - | - | 394 | A | $T_A=25\text{ °C}$ |
| Avalanche energy, single pulse ⁽³⁾ | E_{AS} | - | - | 377 | mJ | $I_D=50\text{ A}$, $R_{GS}=25\text{ }\Omega$ |
| Gate source voltage | V_{GS} | -20 | - | 20 | V | - |
| Power dissipation | P_{tot} | - | - | 156 | W | $T_C=25\text{ °C}$ |
| Operating and storage temperature | T_j , T_{stg} | -55 | - | 150 | °C | IEC climatic category; DIN IEC 68-1: 55/150/56 |

2 Thermal characteristics

Table 3 Thermal characteristics

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|---|------------|--------|------|------|------|-----------------------|
| | | Min. | Typ. | Max. | | |
| Thermal resistance, junction - case, bottom | R_{thJC} | - | 0.45 | 0.8 | °C/W | - |
| Thermal resistance, junction - case, top | R_{thJC} | - | - | 18 | °C/W | - |
| Thermal resistance, junction - ambient, minimal footprint | R_{thJA} | - | - | 62 | °C/W | - |
| Thermal resistance, junction - ambient, 6 cm ² cooling area ⁽²⁾ | R_{thJA} | - | - | 45 | °C/W | - |

⁽¹⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

⁽²⁾ See Diagram 3 for more detailed information

⁽³⁾ See Diagram 13 for more detailed information

3 Electrical characteristics

at $T_j=25\text{ °C}$, unless otherwise specified

Table 4 Static characteristics

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|----------------------------------|---------------|--------|------------|------------|---------------|---|
| | | Min. | Typ. | Max. | | |
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | 120 | - | - | V | $V_{GS}=0\text{ V}$, $I_D=1\text{ mA}$ |
| Gate threshold voltage | $V_{GS(th)}$ | 1.2 | 1.85 | 2.4 | V | $V_{DS}=V_{GS}$, $I_D=112\text{ }\mu\text{A}$ |
| Zero gate voltage drain current | I_{DSS} | - | 0.01 1 | 1 100 | μA | $V_{DS}=120\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ °C}$ $V_{DS}=120\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=125\text{ °C}$ |
| Gate-source leakage current | I_{GSS} | - | 1 | 100 | nA | $V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$ |
| Drain-source on-state resistance | $R_{DS(on)}$ | - | 6.5 7.8 | 8.0 9.5 | m Ω | $V_{GS}=10\text{ V}$, $I_D=50\text{ A}$ $V_{GS}=4.5\text{ V}$, $I_D=25\text{ A}$ |
| Gate resistance | R_G | - | 0.85 | - | Ω | - |
| Transconductance | g_{fs} | 60 | 120 | - | S | $ V_{DS} \geq 2 I_D /R_{DS(on)max}$, $I_D=50\text{ A}$ |

Table 5 Dynamic characteristics

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|--|--------------|--------|------|------|------|--|
| | | Min. | Typ. | Max. | | |
| Input capacitance ¹⁾ | C_{iss} | - | 5600 | 7400 | pF | $V_{GS}=0\text{ V}$, $V_{DS}=60\text{ V}$, $f=1\text{ MHz}$ |
| Output capacitance ¹⁾ | C_{oss} | - | 590 | 770 | pF | $V_{GS}=0\text{ V}$, $V_{DS}=60\text{ V}$, $f=1\text{ MHz}$ |
| Reverse transfer capacitance ¹⁾ | C_{rss} | - | 28 | 42 | pF | $V_{GS}=0\text{ V}$, $V_{DS}=60\text{ V}$, $f=1\text{ MHz}$ |
| Turn-on delay time | $t_{d(on)}$ | - | 11 | - | ns | $V_{DD}=60\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=25\text{ A}$, $R_{G,ext}=1.6\text{ }\Omega$ |
| Rise time | t_r | - | 9 | - | ns | $V_{DD}=60\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=25\text{ A}$, $R_{G,ext}=1.6\text{ }\Omega$ |
| Turn-off delay time | $t_{d(off)}$ | - | 37 | - | ns | $V_{DD}=60\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=25\text{ A}$, $R_{G,ext}=1.6\text{ }\Omega$ |
| Fall time | t_f | - | 13 | - | ns | $V_{DD}=60\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=25\text{ A}$, $R_{G,ext}=1.6\text{ }\Omega$ |

Table 6 Gate charge characteristics²⁾

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|-----------------------|---------------|--------|------|------|------|---|
| | | Min. | Typ. | Max. | | |
| Gate to source charge | Q_{gs} | - | 17.5 | - | nC | $V_{DD}=60\text{ V}$, $I_D=25\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate to drain charge | Q_{gd} | - | 12.9 | - | nC | $V_{DD}=60\text{ V}$, $I_D=25\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$ |
| Switching charge | Q_{sw} | - | 20.1 | - | nC | $V_{DD}=60\text{ V}$, $I_D=25\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate charge total | Q_g | - | 79 | - | nC | $V_{DD}=60\text{ V}$, $I_D=25\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate plateau voltage | $V_{plateau}$ | - | 3.1 | - | V | $V_{DD}=60\text{ V}$, $I_D=25\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$ |
| Output charge | Q_{oss} | - | 79 | - | nC | $V_{DD}=60\text{ V}$, $V_{GS}=0\text{ V}$ |

¹⁾ Defined by design. Not subject to production test.

²⁾ See "Gate charge waveforms" for parameter definition

Table 7 Reverse diode

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|----------------------------------|---------------|--------|------|------|------|--|
| | | Min. | Typ. | Max. | | |
| Diode continuous forward current | I_S | - | - | 109 | A | $T_C=25\text{ °C}$ |
| Diode pulse current | $I_{S,pulse}$ | - | - | 394 | A | $T_C=25\text{ °C}$ |
| Diode forward voltage | V_{SD} | - | 0.88 | 1.2 | V | $V_{GS}=0\text{ V}$, $I_F=50\text{ A}$, $T_j=25\text{ °C}$ |
| Reverse recovery time | t_{rr} | - | 107 | - | ns | $V_R=60\text{ V}$, $I_F=25\text{ A}$, $di_F/dt=100\text{ A}/\mu\text{s}$ |
| Reverse recovery charge | Q_{rr} | - | 220 | - | nC | $V_R=60\text{ V}$, $I_F=25\text{ A}$, $di_F/dt=100\text{ A}/\mu\text{s}$ |

4 Electrical characteristics diagrams

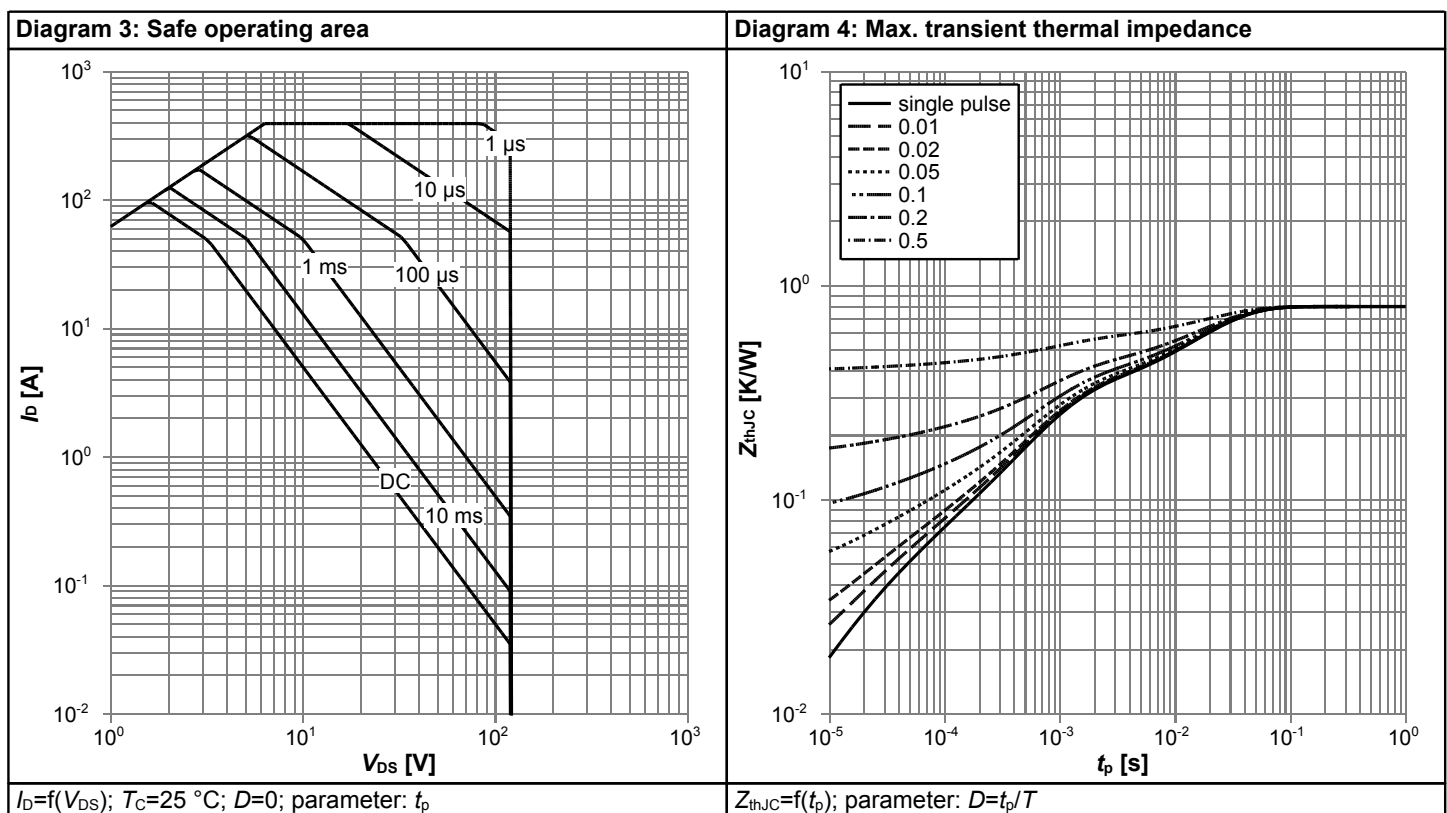
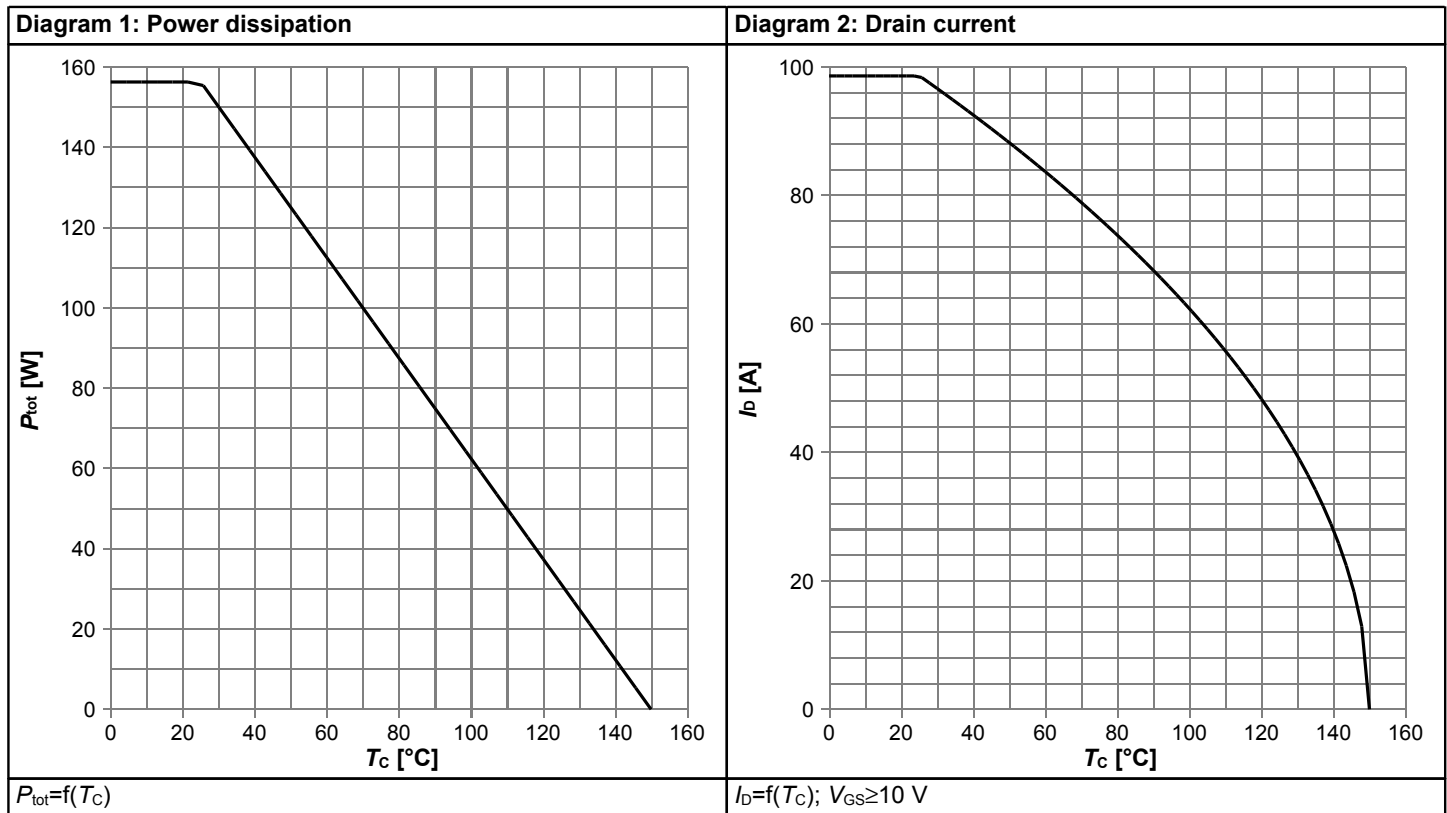
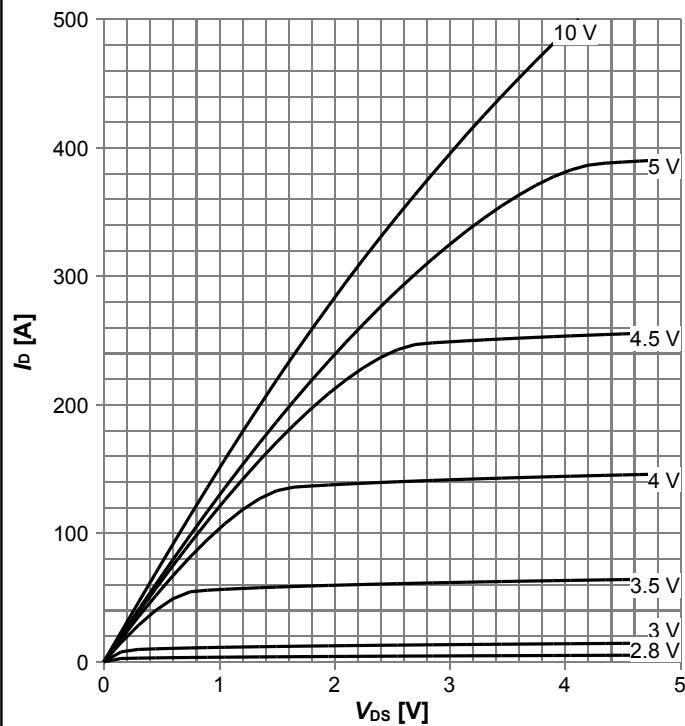
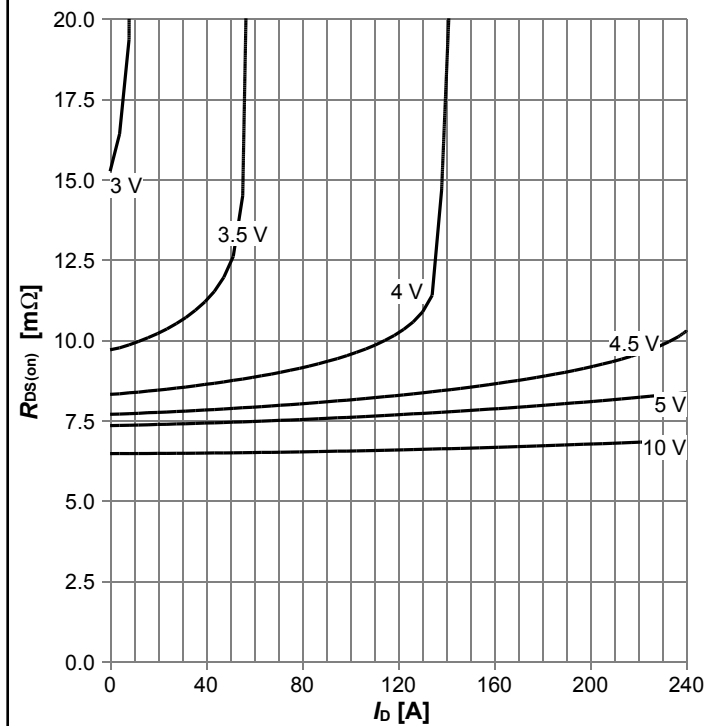


Diagram 5: Typ. output characteristics



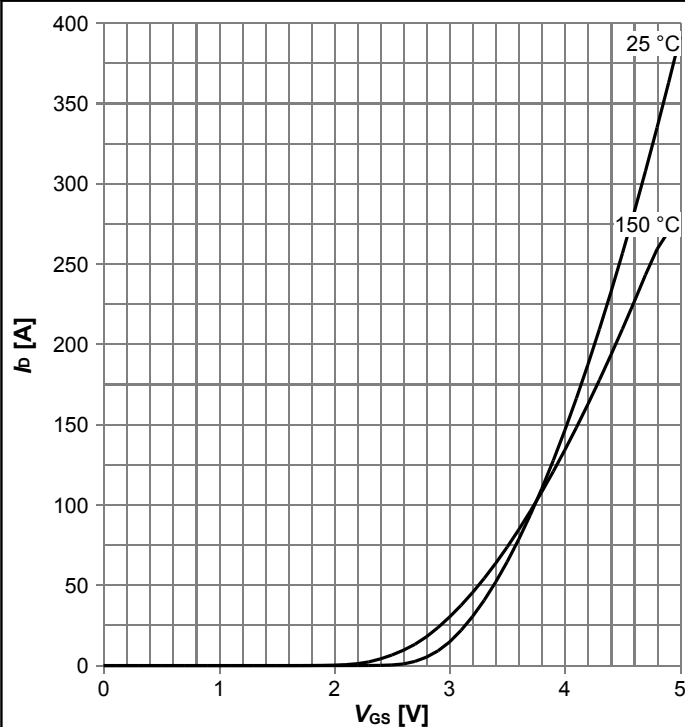
$I_D = f(V_{DS})$, $T_j = 25^\circ\text{C}$; parameter: V_{GS}

Diagram 6: Typ. drain-source on resistance



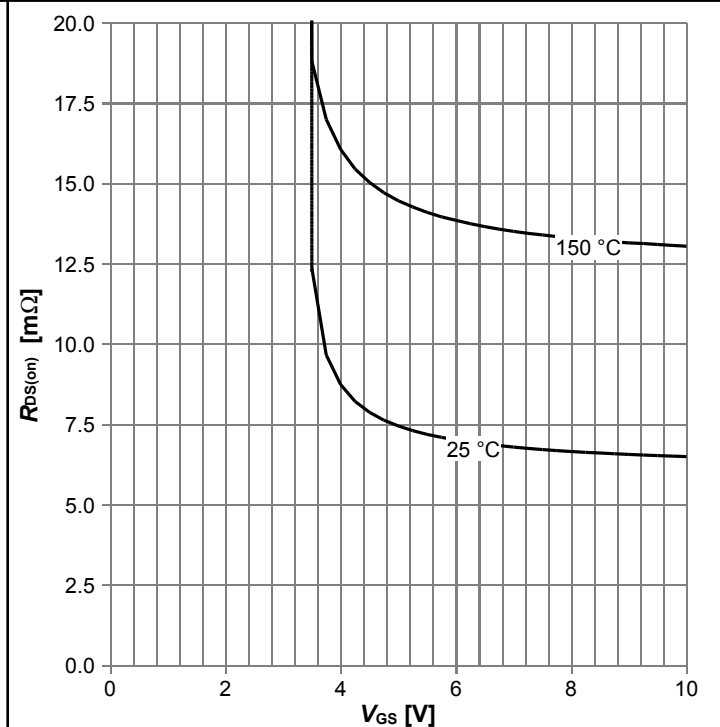
$R_{DS(on)} = f(I_D)$, $T_j = 25^\circ\text{C}$; parameter: V_{GS}

Diagram 7: Typ. transfer characteristics



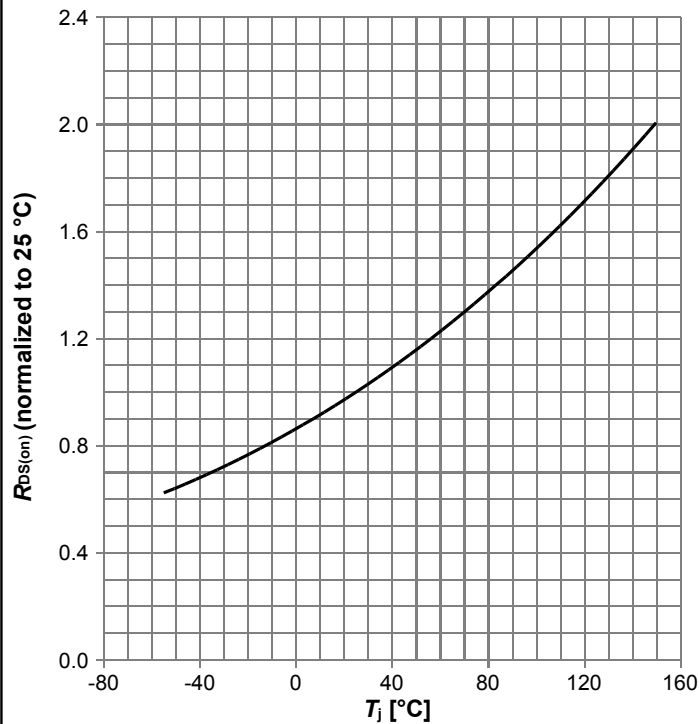
$I_D = f(V_{GS})$, $|V_{DS}| > 2|I_D|R_{DS(on)max}$; parameter: T_j

Diagram 8: Typ. drain-source on resistance



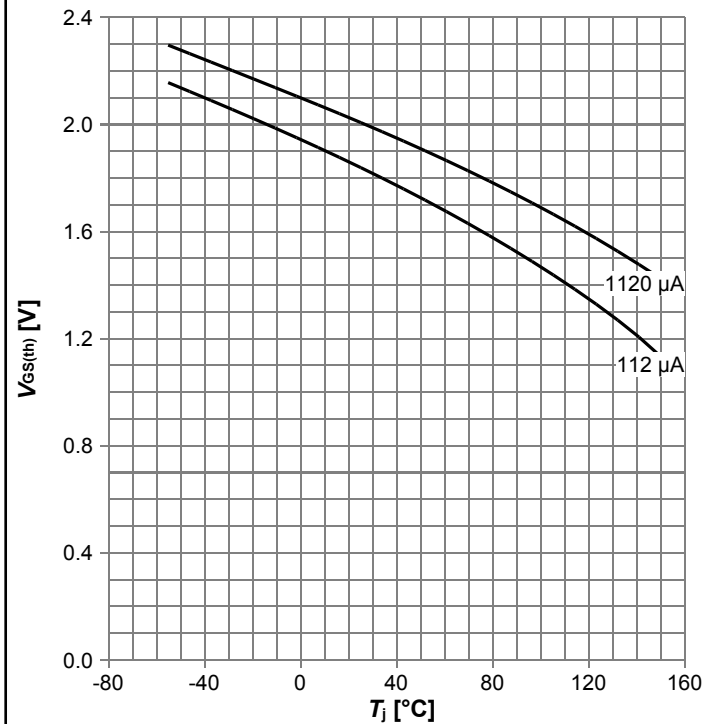
$R_{DS(on)} = f(V_{GS})$, $I_D = 50\text{ A}$; parameter: T_j

Diagram 9: Normalized drain-source on resistance



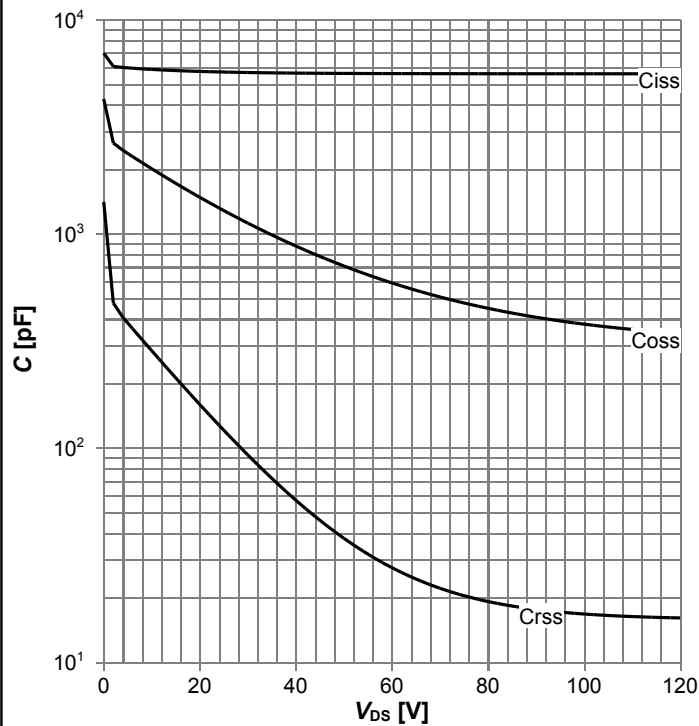
$R_{DS(on)} = f(T_j)$, $I_D = 50$ A, $V_{GS} = 10$ V

Diagram 10: Typ. gate threshold voltage



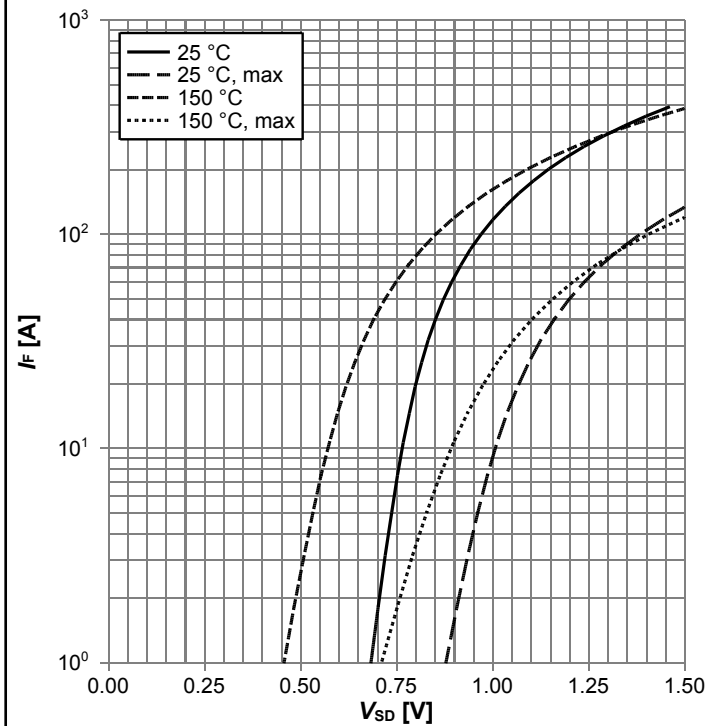
$V_{GS(th)} = f(T_j)$, $V_{GS} = V_{DS}$; parameter: I_D

Diagram 11: Typ. capacitances



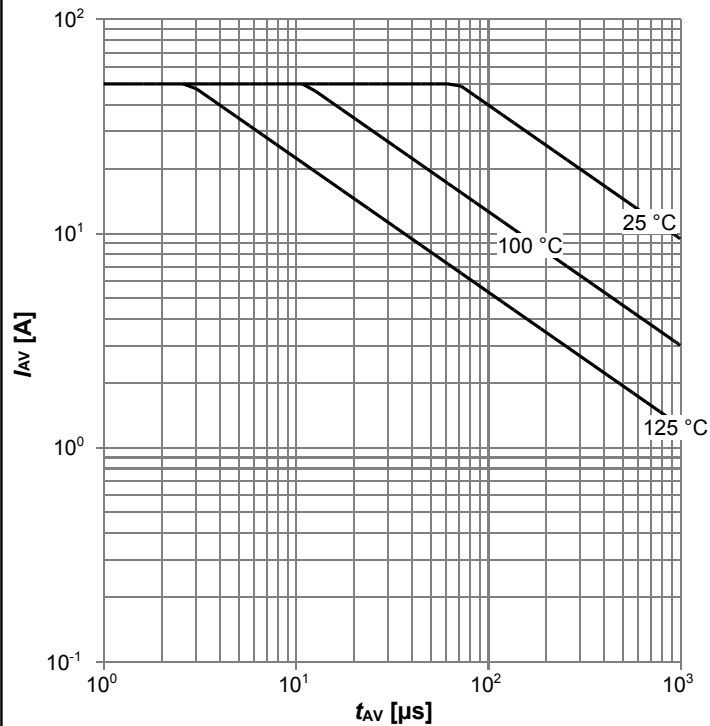
$C = f(V_{DS})$; $V_{GS} = 0$ V; $f = 1$ MHz

Diagram 12: Forward characteristics of reverse diode



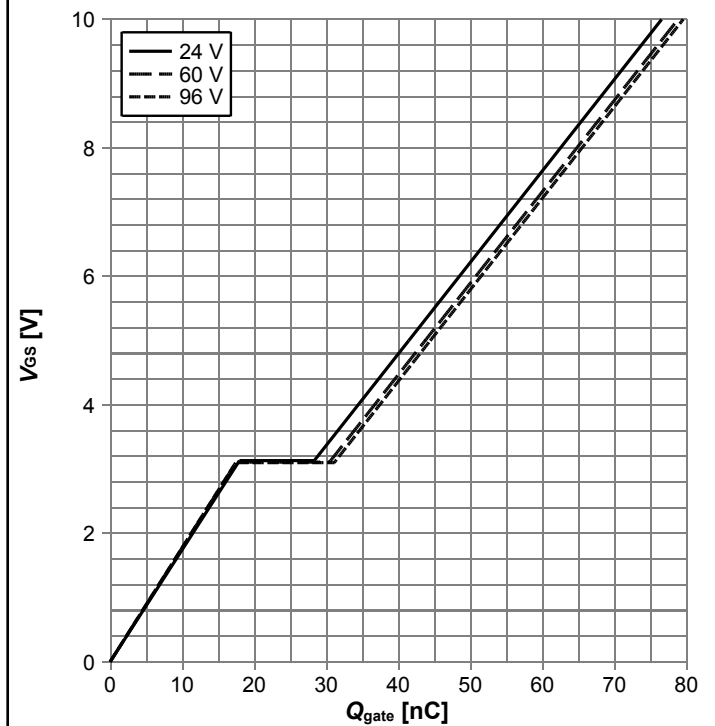
$I_F = f(V_{SD})$; parameter: T_j

Diagram 13: Avalanche characteristics



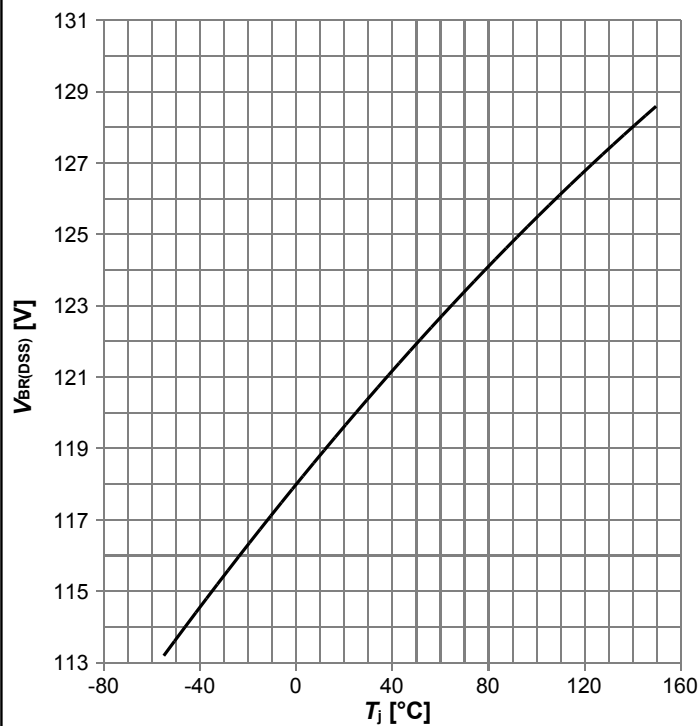
$I_{AS}=f(t_{AV})$; $R_{GS}=25\ \Omega$; parameter: $T_{j,start}$

Diagram 14: Typ. gate charge



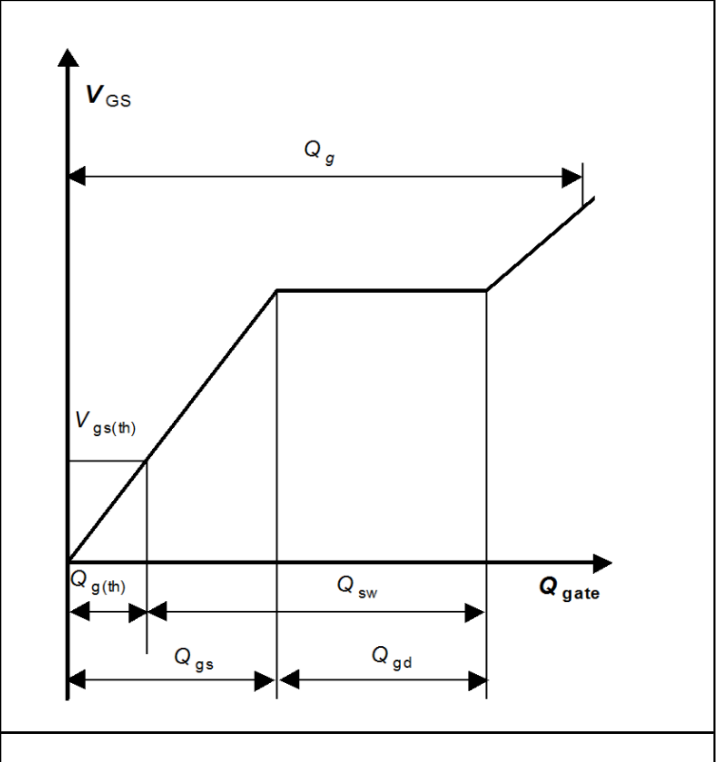
$V_{GS}=f(Q_{gate})$, $I_D=25\text{ A}$ pulsed, $T_j=25\text{ °C}$; parameter: V_{DD}

Diagram 15: Drain-source breakdown voltage

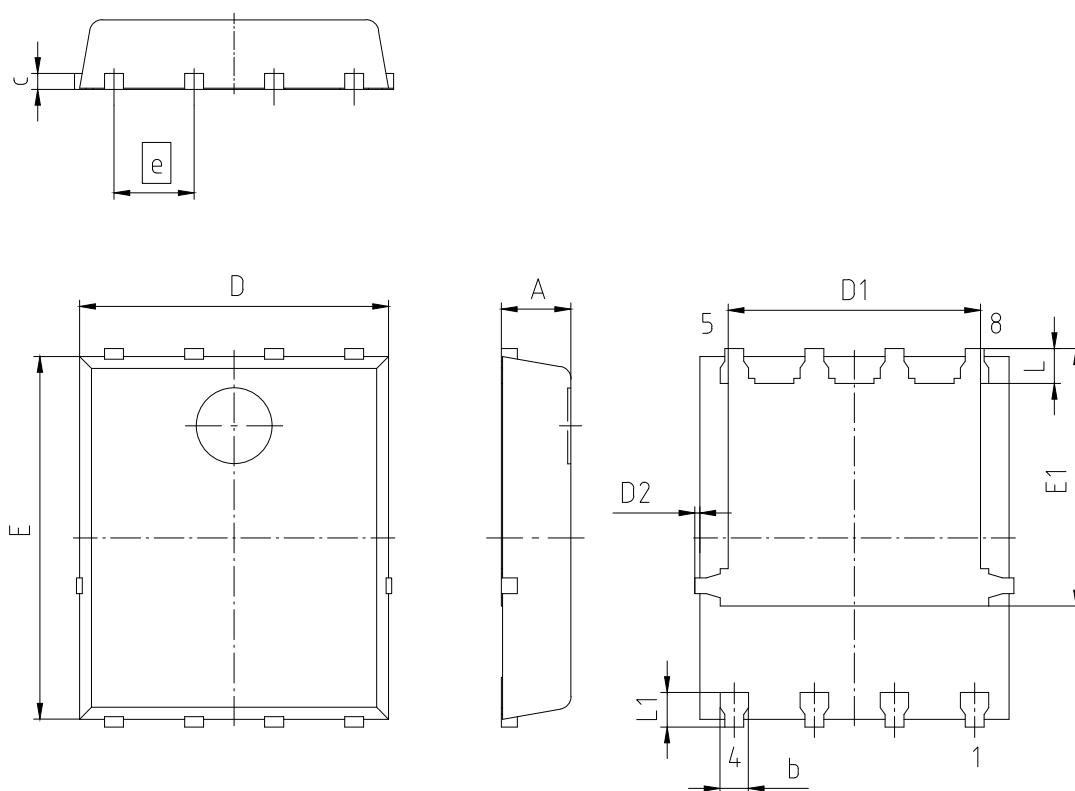


$V_{BR(DSS)}=f(T_j)$; $I_D=1\text{ mA}$

Diagram Gate charge waveforms



5 Package Outlines



| PACKAGE - GROUP NUMBER: PG-TDSON-8-U08 | | |
|--|-------------|------|
| DIMENSIONS | MILLIMETERS | |
| | MIN. | MAX. |
| A | 0.90 | 1.20 |
| b | 0.34 | 0.54 |
| c | 0.15 | 0.35 |
| D | 4.80 | 5.35 |
| D1 | 3.90 | 4.40 |
| D2 | 0.00 | 0.22 |
| E | 5.70 | 6.10 |
| E1 | 4.05 | 4.25 |
| e | 1.27 | |
| L | 0.45 | 0.65 |
| L1 | 0.45 | 0.65 |

- 1) EXCLUDING MOLD FLASH
- 2) REMOVAL ON MOLD GATE
INTRUSION 0.1 MM
PROTRUSION 0.1 MM
- 3) ALL METAL SURFACES ARE PLATED,
EXCEPT AREA OF CUT

Figure 1 Outline PG-TDSON-8, dimensions in mm

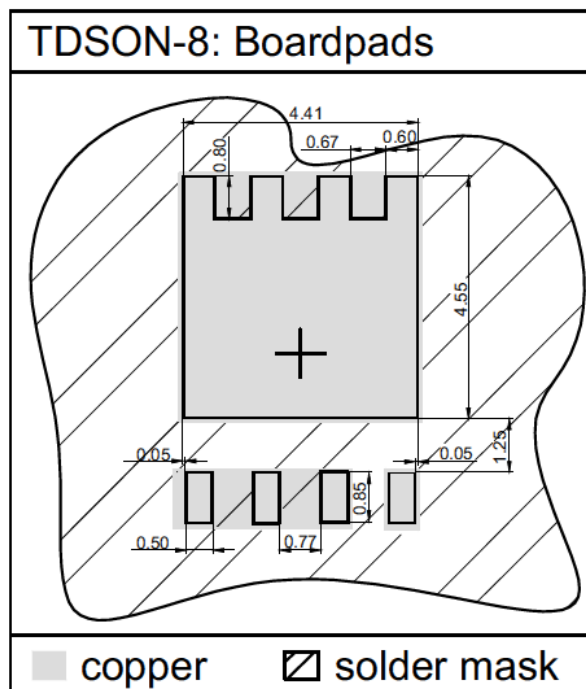


Figure 2 Outline Footprint (TDSON-8)



Rev. 2.1, 2022-11-09

Revision History

BSC080N12LS

Revision: 2022-11-09, Rev. 2.1

Previous Revision

| Revision | Date | Subjects (major changes since last revision) |
|----------|------------|---|
| 2.0 | 2019-11-25 | Release of final version |
| 2.1 | 2022-11-09 | Bug fix, update outline drawing and footnotes |

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